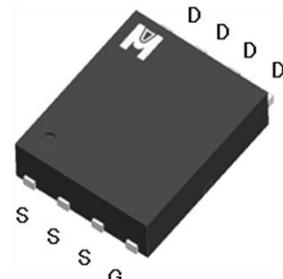
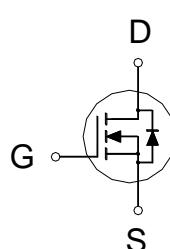


N-Channel Logic Level Enhancement Mode Field Effect Transistor

Product Summary:

BV <sub>DSS</sub>	60V
R <sub>DSON</sub> (MAX.)	8mΩ
I <sub>D</sub>	60A



UIS, R<sub>G</sub> 100% Tested

RoHS & Halogen Free & TSCA Compliant



**ABSOLUTE MAXIMUM RATINGS (T<sub>A</sub> = 25 °C Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS		SYMBOL	LIMITS	UNIT
Gate-Source Voltage		V <sub>GS</sub>	±20	V
Continuous Drain Current	T <sub>C</sub> = 25 °C	I <sub>D</sub>	60	A
	T <sub>C</sub> = 100 °C		35	
Pulsed Drain Current <sup>1,3</sup>		I <sub>DM</sub>	170	
Avalanche Current		I <sub>AS</sub>	60	
Avalanche Energy	L = 0.1mH, ID=60A, RG=25Ω	E <sub>AS</sub>	180	mJ
Repetitive Avalanche Energy <sup>2</sup>	L = 0.05mH	E <sub>AR</sub>	90	
Power Dissipation	T <sub>C</sub> = 25 °C	P <sub>D</sub>	50	W
	T <sub>C</sub> = 100 °C		20	
Operating Junction & Storage Temperature Range		T <sub>j</sub> , T <sub>stg</sub>	-55 to 150	°C

100% UIS testing in condition of V<sub>D</sub>=30V, L=0.1mH, V<sub>G</sub>=10V, I<sub>L</sub>=36A, Rated V<sub>DS</sub>=60V N-CH

**THERMAL RESISTANCE RATINGS**

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNIT
Junction-to-Case	R <sub>θJC</sub>		2.5	°C / W
Junction-to-Ambient	R <sub>θJA</sub>		75	

<sup>1</sup>Pulse width limited by maximum junction temperature.

<sup>2</sup>Duty cycle < 1%

<sup>3</sup>The value of R<sub>θJA</sub> is measured with the device mounted on 1in<sup>2</sup> FR-4 board with 2oz.

Copper, in a still air environment with T<sub>A</sub> =25°C.

<sup>4</sup>Guarantee by Engineering test

ELECTRICAL CHARACTERISTICS ( $T_J = 25^\circ\text{C}$ , Unless Otherwise Noted)

PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	60			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	1.0	2.0	3.0	
Gate-Body Leakage	$I_{\text{GSS}}$	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 20\text{V}$			$\pm 100$	nA
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = 48\text{V}, V_{\text{GS}} = 0\text{V}$			1	$\mu\text{A}$
		$V_{\text{DS}} = 40\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$			25	
On-State Drain Current <sup>1</sup>	$I_{\text{D}(\text{ON})}$	$V_{\text{DS}} = 5\text{V}, V_{\text{GS}} = 10\text{V}$	60			A
Drain-Source On-State Resistance <sup>1</sup>	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 10\text{V}, I_D = 40\text{A}$		6.6	8.0	$\text{m}\Omega$
		$V_{\text{GS}} = 4.5\text{V}, I_D = 20\text{A}$		11	14	
Forward Transconductance <sup>1</sup>	$g_{\text{fs}}$	$V_{\text{DS}} = 5\text{V}, I_D = 40\text{A}$		50		S
DYNAMIC						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 25\text{V}, f = 1\text{MHz}$		2869		pF
Output Capacitance	$C_{\text{oss}}$			296		
Reverse Transfer Capacitance	$C_{\text{rss}}$			68		
Gate Resistance	$R_g$	$V_{\text{GS}} = 15\text{mV}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$		2.0		$\Omega$
Total Gate Charge <sup>1,2</sup>	$Q_g$	$V_{\text{DS}} = 30\text{V}, V_{\text{GS}} = 10\text{V}, I_D = 40\text{A}$		38		nC
Gate-Source Charge <sup>1,2</sup>	$Q_{\text{gs}}$			17		
Gate-Drain Charge <sup>1,2</sup>	$Q_{\text{gd}}$			5.2		
Turn-On Delay Time <sup>1,2</sup>	$t_{\text{d}(\text{on})}$	$V_{\text{DS}} = 30\text{V}, I_D = 5\text{A}, V_{\text{GS}} = 10\text{V}, R_G = 6\Omega$		9.7		nS
Rise Time <sup>1,2</sup>	$t_r$			7.8		
Turn-Off Delay Time <sup>1,2</sup>	$t_{\text{d}(\text{off})}$			28.2		
Fall Time <sup>1,2</sup>	$t_f$			4.3		
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ( $T_c = 25^\circ\text{C}$ )						
Continuous Current	$I_s$				60	A
Pulsed Current <sup>3</sup>	$I_{\text{SM}}$				170	
Forward Voltage <sup>1</sup>	$V_{\text{SD}}$	$I_F = I_s, V_{\text{GS}} = 0\text{V}$			1.3	V
Reverse Recovery Time	$t_{\text{rr}}$	$I_F = 40\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		30		nS
Reverse Recovery Charge	$Q_{\text{rr}}$			150		nC



EMB08N06H

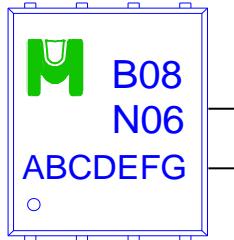
<sup>1</sup>Pulse test : Pulse Width  $\leq$  300  $\mu$ sec, Duty Cycle  $\leq$  2%.

<sup>2</sup>Independent of operating temperature.

<sup>3</sup>Pulse width limited by maximum junction temperature.

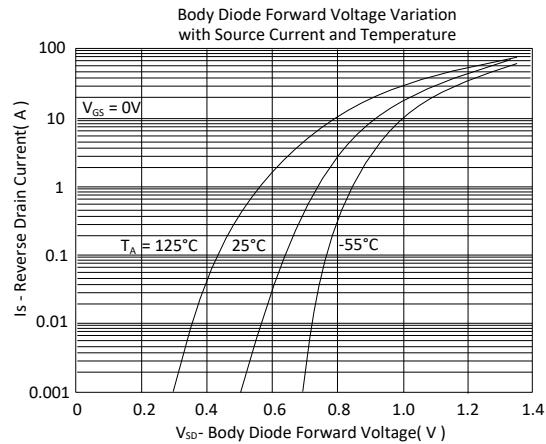
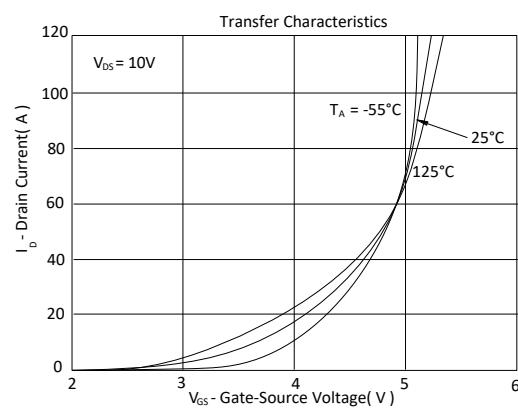
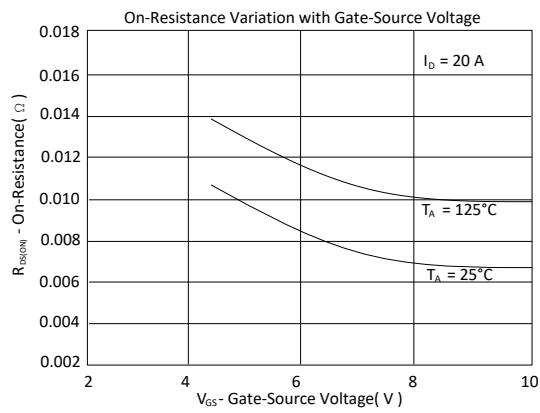
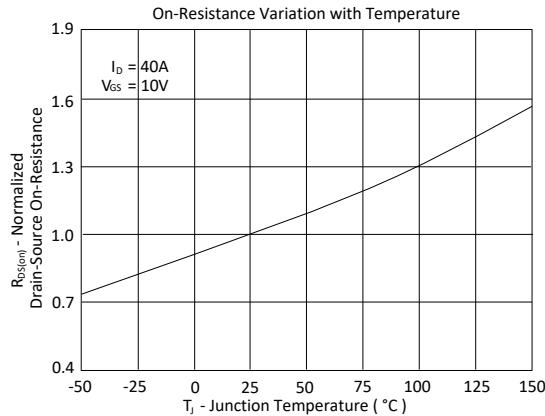
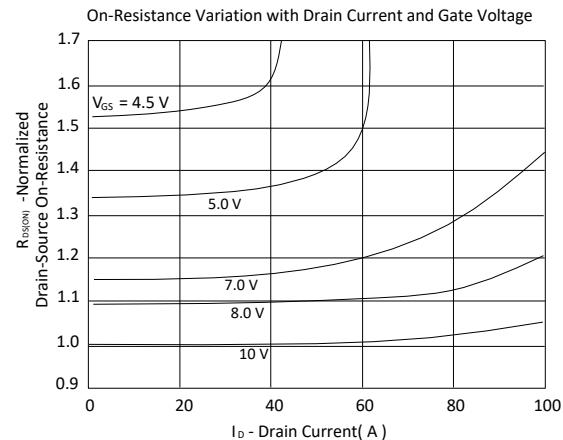
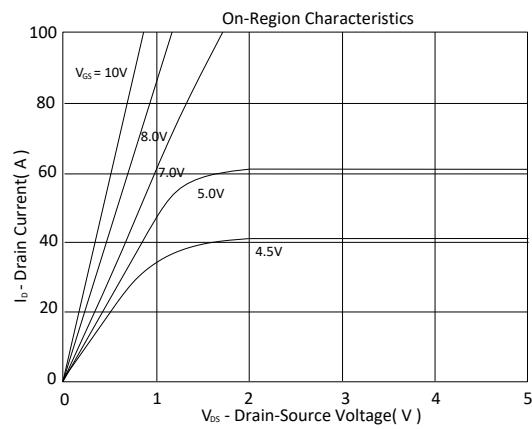
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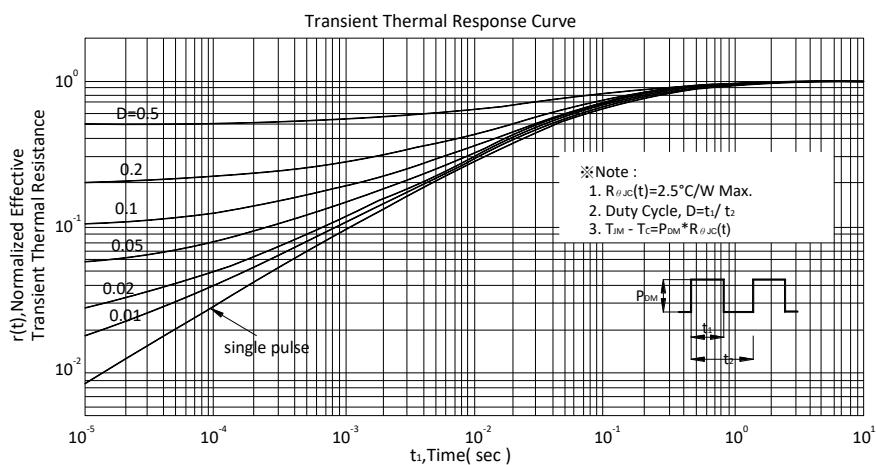
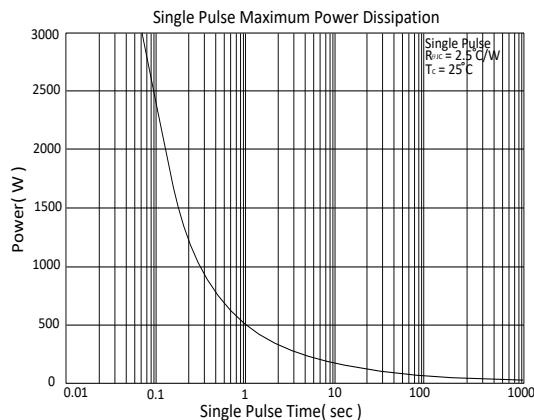
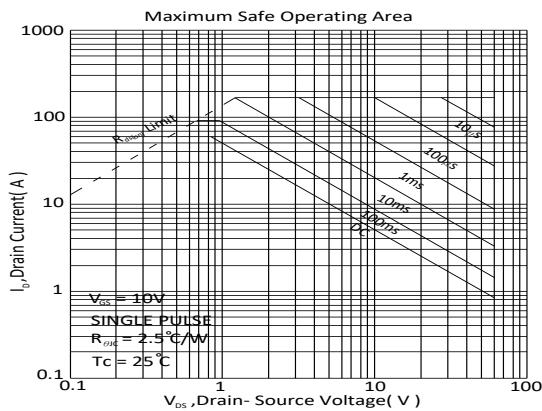
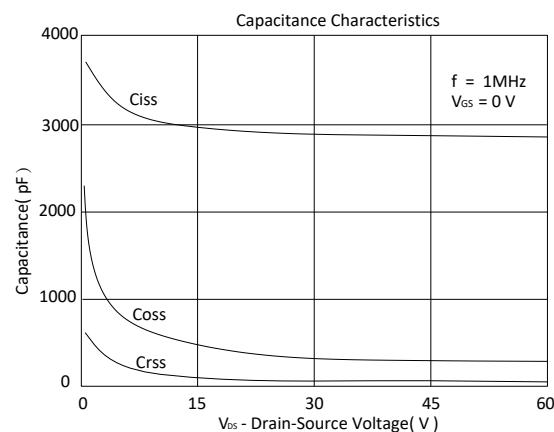
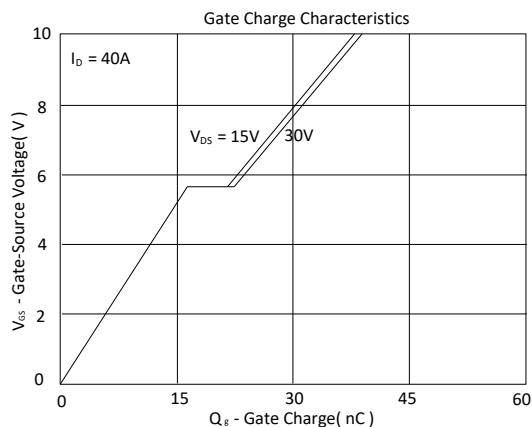
Device Name: EMB08N06H for EDFN 5 x 6



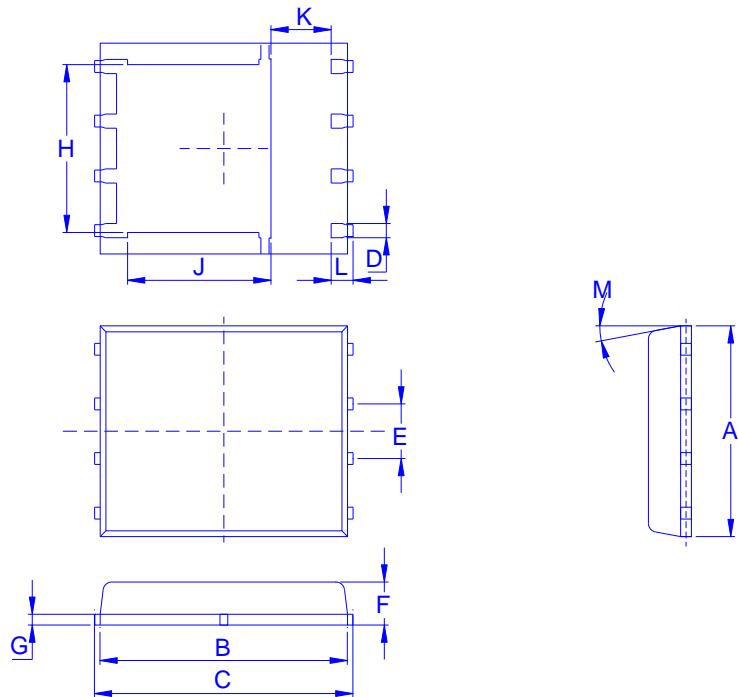
- B08N06: Device Name
- ABCDEFG: Date Code
- A: Assembly House
- B: Year(A:2008 B:2009 C:2010....)
- C: Month(A:01 B:02 C:03 D:04 E:05 F:06 G:07 H:08 I:09 J:10 K:11 L:12)
- DEFG: Serial No.

TYPICAL CHARACTERISTICS





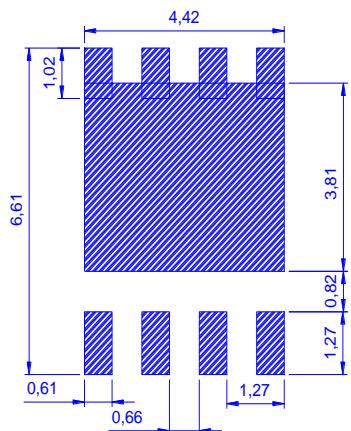
Outline Drawing



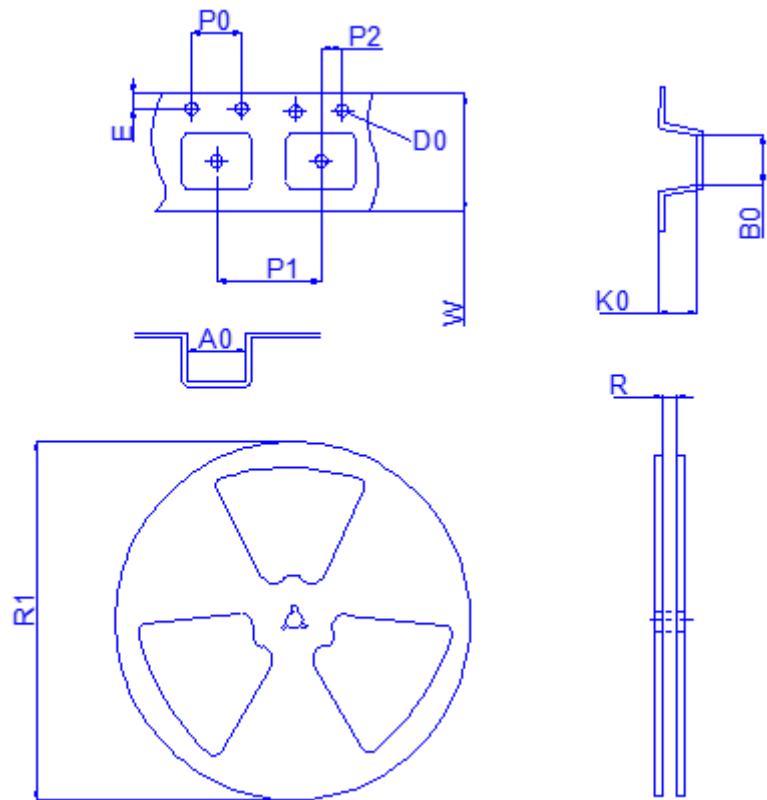
Dimension in mm

Dimension	A	B	C	D	E	F	G	H	J	K	L	M
Min	4.8	5.55	5.9	0.3	1.17	0.85	0.15	3.61	3.18	1	0.38	0°
Typ.	4.9	5.7	6	0.4	1.27	0.95	0.2	3.87	3.44	1.2	0.4	
Max	5.4	5.85	6.15	0.51	1.37	1.17	0.34	4.31	3.78	1.39	0.71	12°

Recommended minimum pads



Tape&Reel Information:2500pcs/Reel



Package	EDFN5X6
Reel	13"
Device orientation	<b>FEED DIRECTION</b>   

Dimension in mm

Dimension	Carrier tape								W	Reel	
	A0	B0	D0	E	K0	P0	P1	P2		R	R1
Typ.	6.4	5.3	1.5	1.8	1.6	4	8	2	12	12.4	330
±	0.2	0.2	0.1	0.1	0.6	0.1	0.1	0.1	0.3	2	2